Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/936,565	SAUK, JOHN J.
Examiner	Art Unit
Christopher H. Yaen	1643

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

DATE 2/16/2006 2/16/2006	CHY
2/16/2006	СНҮ
2/16/2006	СНҮ
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